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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded -</u> <u>Microcontrollers</u>"

Details

•XF

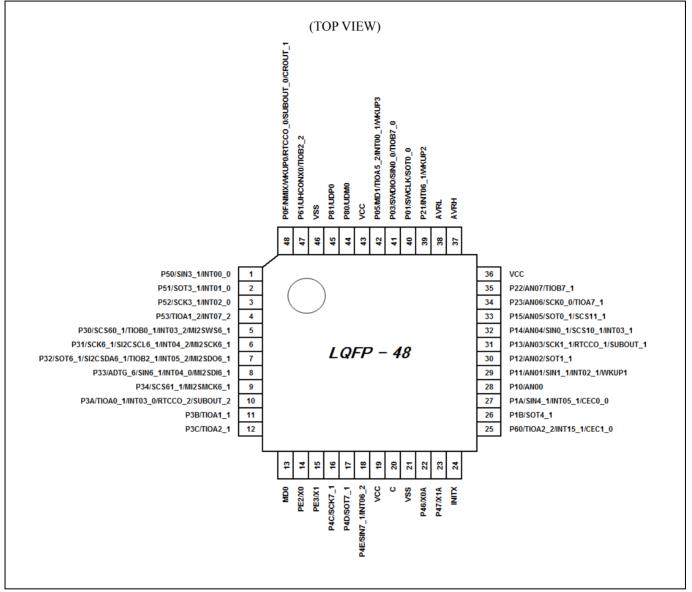
| Product Status Active Core Processor ARM® Cortex®-M0+ Core Size 32-Bit Single-Core | |
|---|--|
| | |
| Core Size 32-Bit Single-Core | |
| | |
| Speed 40MHz | |
| Connectivity CSIO, I ² C, LINbus, UART/USART, USB | |
| Peripherals I ² S, LVD, POR, PWM, WDT | |
| Number of I/O 38 | |
| Program Memory Size 128KB (128K x 8) | |
| Program Memory Type FLASH | |
| EEPROM Size - | |
| RAM Size 16K x 8 | |
| Voltage - Supply (Vcc/Vdd)1.65V ~ 3.6V | |
| Data Converters A/D 8x12b | |
| Oscillator Type Internal | |
| Operating Temperature-40°C ~ 105°C (TA) | |
| Mounting Type Surface Mount | |
| Package / Case 48-WFQFN Exposed Pad | |
| Supplier Device Package48-QFN (7x7) | |
| Purchase URL https://www.e-xfl.com/product-detail/infineon-technologies/s6e1c32c0agn20000 | |

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong



FPT-48P-M49

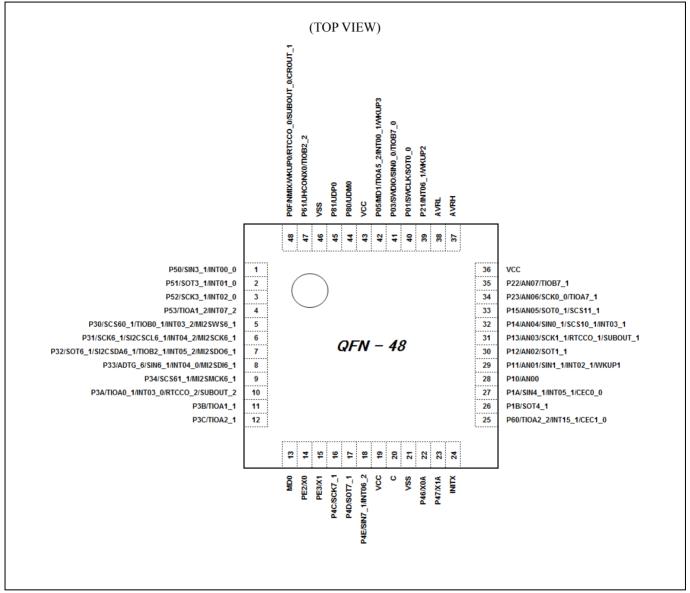


Note:

The number after the underscore ("_") in a pin name such as XXX_1 and XXX_2 indicates the relocated port number. The channel on such pin has multiple functions, each of which has its own pin name. Use the Extended Port Function Register (EPFR) to select the pin to be used.



LCC-48P-M74



Note:

The number after the underscore ("_") in a pin name such as XXX_1 and XXX_2 indicates the relocated port number. The channel on such pin has multiple functions, each of which has its own pin name. Use the Extended Port Function Register (EPFR) to select the pin to be used.



WLCSP

_

| | TBD | |
|-------|-----|--|
| | | |
| Note: | | |

The number after the underscore ("_") in a pin name such as XXX_1 and XXX_2 indicates the relocated port number. The channel on such pin has multiple functions, each of which has its own pin name. Use the Extended Port Function Register (EPFR) to select the pin to be used.



| | | | | Pin | no. | |
|----------------------------|--------------------|---|-------------------|-------------------|-------------------|----------------|
| Pin function | Pin name | Function description | LQFP-64 QFN-64 | LQFP-48 QFN-48 | LQFP-32 QFN-32 | WLCSP (TBD) |
| | SIN1_1 | Multi-function serial interface ch.1 input pin | 41 | 29 | 19 | - |
| | SOT1_1 (SDA1_1) | Multi-function serial interface ch.1 output pin. This pin operates as SOT1 when used as a UART/CSIO/LIN pin (operation mode 0 to 3) and as SDA1 when used as an I2C pin (operation mode 4). | 42 | 30 | 20 | - |
| Multi-function Serial 1 | SCK1_1 (SCL1_1) | Multi-function serial interface ch.1 clock I/O pin. This pin operates as SCK1 when used as a CSIO pin (operation mode 2) and as SCL1 when used as an I2C pin (operation mode 4). | 43 | 31 | 21 | - |
| | SCS10_1 | Multi-function serial interface ch.1 serial chip select 0 input/output pin. | 44 | 32 | - | - |
| | SCS11_1 | Multi-function serial interface ch.1 serial chip select 1 output pin. | 45 | 33 | - | - |
| | SIN3_1 | Multi-function serial interface ch.3 input pin | 1 | 1 | 2 | - |
| Multi-function Serial 3 | SOT3_1 (SDA3_1) | Multi-function serial interface ch.3 output pin. This pin operates as SOT3 when used as a UART/CSIO/LIN pin (operation mode 0 to 3) and as SDA3 when used as an I2C pin (operation mode 4). | 2 | 2 | 3 | - |
| | SCK3_1 (SCL3_1) | Multi-function serial interface ch.3 clock I/O pin. This pin operates as SCK3 when used as a CSIO (operation mode 2) and as SCL3 when used as an I2C pin (operation mode 4). | 3 | 3 | 4 | - |
| | SIN4_1 | Multi-function serial interface ch.4 input pin | 38 | 27 | - | - |
| | SOT4_1 (SDA4_1) | Multi-function serial interface ch.4 output pin. This pin operates as SOT4 when used as a UART/CSIO/LIN pin (operation mode 0 to 3) and as SDA4 when used as an I2C pin (operation mode 4). | 37 | 26 | - | - |
| Multi-function Serial 4 | SCK4_1 (SCL4_1) | Multi-function serial interface ch.4 clock I/O pin. This pin operates as SCK4 when used as a CSIO (operation mode 2) and as SCL4 when used as an I2C pin (operation mode 4). | 36 | - | - | - |
| | CTS4_1 | Multi-function serial interface ch4 CTS input pin | 35 | - | - | - |
| | RTS4_1 | Multi-function serial interface ch4 RTS output pin | 34 | - | - | - |



Surface Mount Type

Surface mount packaging has longer and thinner leads than lead-insertion packaging, and therefore leads are more easily deformed or bent. The use of packages with higher pin counts and narrower pin pitch results in increased susceptibility to open connections caused by deformed pins, or shorting due to solder bridges.

You must use appropriate mounting techniques. Spansion recommends the solder reflow method, and has established a ranking of mounting conditions for each product. Users are advised to mount packages in accordance with Spansion ranking of recommended conditions.

Lead-Free Packaging

CAUTION: When ball grid array (BGA) packages with Sn-Ag-Cu balls are mounted using Sn-Pb eutectic soldering, junction strength may be reduced under some conditions of use.

Storage of Semiconductor Devices

Because plastic chip packages are formed from plastic resins, exposure to natural environmental conditions will cause absorption of moisture. During mounting, the application of heat to a package that has absorbed moisture can cause surfaces to peel, reducing moisture resistance and causing packages to crack. To prevent, do the following:

- (1) Avoid exposure to rapid temperature changes, which cause moisture to condense inside the product. Store products in locations where temperature changes are slight.
- (2) Use dry boxes for product storage. Products should be stored below 70% relative humidity, and at temperatures between 5 °C and 30 °C.

When you open Dry Package that recommends humidity 40% to 70% relative humidity.

- (3) When necessary, Spansion packages semiconductor devices in highly moisture-resistant aluminum laminate bags, with a silica gel desiccant. Devices should be sealed in their aluminum laminate bags for storage.
- (4) Avoid storing packages where they are exposed to corrosive gases or high levels of dust.

Baking

Packages that have absorbed moisture may be de-moisturized by baking (heat drying). Follow the Spansion recommended conditions for baking.

Condition: 125°C/24 h

Static Electricity

Because semiconductor devices are particularly susceptible to damage by static electricity, you must take the following precautions:

- (1) Maintain relative humidity in the working environment between 40% and 70%.
- Use of an apparatus for ion generation may be needed to remove electricity.
- (2) Electrically ground all conveyors, solder vessels, soldering irons and peripheral equipment.
- (3) Eliminate static body electricity by the use of rings or bracelets connected to ground through high resistance (on the level of 1 $M\Omega$).

Wearing of conductive clothing and shoes, use of conductive floor mats and other measures to minimize shock loads is recommended.

- (4) Ground all fixtures and instruments, or protect with anti-static measures.
- (5) Avoid the use of styrofoam or other highly static-prone materials for storage of completed board assemblies.



Notes on Power-on

Turn power on/off in the following order or at the same time.

Turning on : VCC \rightarrow AVRH Turning off : AVRH \rightarrow VCC

Serial Communication

There is a possibility to receive wrong data due to the noise or other causes on the serial communication.

Therefore, design a printed circuit board so as to avoid noise.

Consider the case of receiving wrong data due to noise; perform error detection such as by applying a checksum of data at the end. If an error is detected, retransmit the data.

Differences in Features Among the Products with Different Memory Sizes and Between Flash Memory Products and MASK Products

The electric characteristics including power consumption, ESD, latch-up, noise characteristics, and oscillation characteristics among the products with different memory sizes and between Flash memory products and MASK products are different because chip layout and memory structures are different.

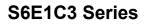
If you are switching to use a different product of the same series, please make sure to evaluate the electric characteristics.

Pull-Up Function of 5 V Tolerant I/O

Please do not input the signal more than VCC voltage at the time of Pull-Up function use of 5 V tolerant I/O.

Handling when Using Debug Pins

When debug pins (SWDIO/SWCLK) are set to GPIO or other peripheral functions, set them as output only; do not set them as input.





Each pin status

The meaning of the symbols in the pin status table is as follows.

- IS Digital output is disabled. (Hi-Z) Pull up register is off. Digital input is shut off by fixed 0.
- IE Digital output is disabled. (Hi-Z) Pull up register is off. Digital input is not shut off.
- IP Digital output is disabled. (Hi-Z) Pull up register is defined by the value of the PCR register. Digital input is not shut off.
- IE/IS Digital output is disabled. (Hi-Z) Pull up register is off. Digital input is shut off in case of the OSC stop. Digital input is not shut off in case of the OSC operation.
- OE The OSC is in operation state. However, it may be stopped in some operation mode of the CPU.
- For detail, see chapter "Low Power Consumption Mode" in peripheral manual.
- OS The OSC is in stop state. (Hi-Z)
- UE USB I/O function is controlled by USB controller.
- US USB I/O function is disabled(Hi-Z)
- PC Digital output and pull up register is controlled by the register in the GPIO or peripheral function. Digital input is not shut off
- CP Digital output is controlled by the register in the GPIO or peripheral function. Pull up register is off. Digital input is not shut off.
- HC Digital output and pull up register is maintained the status that is immediately prior to entering the current CPU state. Digital input is not shut off
- HS Digital output and pull up register is maintained the status that is immediately prior to entering the current CPU state. Digital input is shut off
- GS Digital output and pull up register is copied the GPIO status that is immediately prior to entering the current CPU state and the status is maintained. Digital input is shut off

Additional note

Additional note is described below.

- *1 In this type, when internal oscillation function is selected, digital output is disabled. (Hi-Z) pull up register is off, digital input is shut off by fixed 0.
- *2 In this type, when Digital I/O function is selected, internal oscillation function is disabled.
- *3 In this type, when analog input function is selected, digital output is disabled, (Hi-Z). pull up register is off, digital input is shut off by fixed 0.
- *4 In this type, when Digital I/O function is selected, analog input function is not available.
- *5 In this case, PCR register is initialized to "1". Pull up register is on.
- In this type, when Digital I/O function is selected, USB I/O function is disabled.
- This pin does not have pull up register.
- ^{*7} In this type, when USB I/O function is selected, digital output is disabled. (Hi-Z), digital input is shut off by fixed 0.



| | Symbol | | | Va | lue | | |
|-------------------|---------------------------|----------------|--|------|------|------|---------|
| Parameter | (Pin Name) | Co | nditions | Тур | Max | Unit | Remarks |
| | | | Ta=25°C Vcc=3.3 V | 12.4 | 52.4 | μA | *1, *2 |
| | I _{ССН} (VCC) | Stop mode | Ta=25°C Vcc=1.65 V | 12.0 | 52.0 | μA | *1, *2 |
| | | | Ta=105°C Vcc=3.6 V | - | 597 | μA | *1, *2 |
| Power | | Sub timer mode | Ta=25°C Vcc=3.3 V 32 kHz Crystal oscillation | 15.6 | 55.6 | μA | *1, *2 |
| | I _{ССТ} (VCC) | | Ta=25°C Vcc=1.65 V 32 kHz Crystal oscillation | 15.0 | 55.0 | μA | *1, *2 |
| supply current | | | Ta=105°C Vcc=3.6 V 32 kHz Crystal oscillation | - | 601 | μA | *1, *2 |
| | | | Ta=25°C Vcc=3.3 V 32 kHz Crystal oscillation | 13.2 | 53.2 | μA | *1, *2 |
| | I _{CCR} (VCC) | RTC mode | Ta=25°C Vcc=1.65 V 32 kHz Crystal oscillation | 12.7 | 52.7 | μA | *1, *2 |
| | | | Ta=105℃ Vcc=3.6 V 32 kHz Crystal oscillation | - | 598 | μA | *1, *2 |

*1: All ports are fixed. LVD off. Flash off.

*2: When CALDONE bit(CAL_CTL:CALDONE) is "1". In case of "0", Bipolar Vref current is added.



LVD Current

(V_{CC}=1.65 V to 3.6 V, V_{SS}= 0 V, T_A=- 40°C to +105°C)

| Parameter | Symbol | Pin | Conditions | Va | Value | | Remarks | |
|--|--------|------|------------------------|------|-------|-----------|--------------------------------|--|
| Falameter | Symbol | Name | Conditions Typ Max Uni | | Unit | Reillarks | | |
| Low-Voltage | | | | 0.15 | 0.3 | μA | For occurrence of reset | |
| detection circuit (LVD) power supply current | ICCLVD | VCC | At operation | 0.10 | 0.3 | μA | For occurrence of interrupt | |

Bipolar Vref Current

(V_{CC}=1.65 V to 3.6 V, V_{SS}= 0 V, T_A=- 40°C to +105°C)

| Parameter | Symbol | Pin | Conditions | Va | lue | Unit | Remarks |
|-------------------------|--------------------|------|--------------|-----|-----|------|---------|
| Farameter Symbol | Symbol | Name | Conditions | Тур | Max | Unit | Remarks |
| Bipolar Vref Current | I _{CCBGR} | VCC | At operation | 100 | 200 | μA | |

Flash Memory Current

(V_{CC}=1.65 V to 3.6 V, V_{SS}= 0 V, T_A=- 40°C to +105°C)

| Parameter | Symbol | Pin | n Conditions Val | | lue | Unit | Remarks |
|---|----------------------|------|------------------|-----|-----|------|---------|
| Farameter | Symbol | Name | Conditions | Тур | Max | Unit | Remarks |
| Flash memory write/erase current | I _{CCFLASH} | VCC | At Write/Erase | 4.4 | 5.6 | mA | |

A/D converter Current

(V_{CC}=1.65 V to 3.6 V, V_{SS}= 0 V, T_A=- 40°C to +105°C)

| Parameter | Symbol | Pin | Conditions | Va | ue | Unit | Remarks |
|-------------------------|-------------------|------|--------------|------|------|------|------------|
| Falallielei | Symbol | Name | Conditions | Тур | Max | Unit | Remarks |
| Power supply current | I _{CCAD} | VCC | At operation | 0.5 | 0.75 | mA | |
| Reference power supply | | AVRH | At operation | 0.69 | 1.3 | mA | AVRH=3.6 V |
| current (AVRH) | ICCAVRH | AVKU | At stop | 0.1 | 1.3 | μA | |



11.4.3 Built-in CR Oscillation Characteristics

Built-in High-Speed CR

(V_{CC}= 1.65 V to 3.6 V, V_{SS} = 0 V, T_A=- 40°C to +105°C)

| Parameter | Symbol | Conditions | | Value | | Unit | Remarks | |
|---------------------------------|-------------------|-------------------------|------|-------|------|------|-------------------|--|
| Farameter | Symbol | Conditions | Min | Тур | Max | Unit | | |
| Clock frequency | F _{CRH} | Ta = - 40°C to + 105°C, | 7.84 | 8 | 8.16 | MHz | After trimming *1 | |
| Frequency stabilization time | t _{CRWT} | - | - | - | 300 | μs | *2 | |

*1: In the case of using the values in CR trimming area of Flash memory at shipment for frequency trimming/temperature trimming.

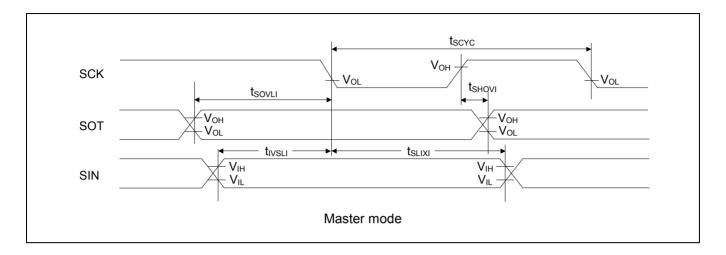
*2: This is time from the trim value setting to stable of the frequency of the High-speed CR clock. After setting the trim value, the period when the frequency stability time passes can use the High-speed CR clock as a source clock.

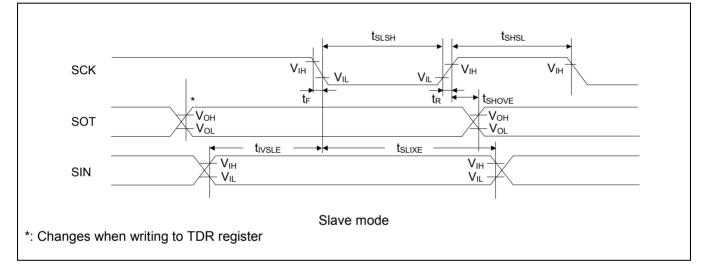
Built-in Low-Speed CR

(V_{CC}= 1.65 V to 3.6 V, V_{SS}= 0 V, T_A=- 40°C to +105°C)

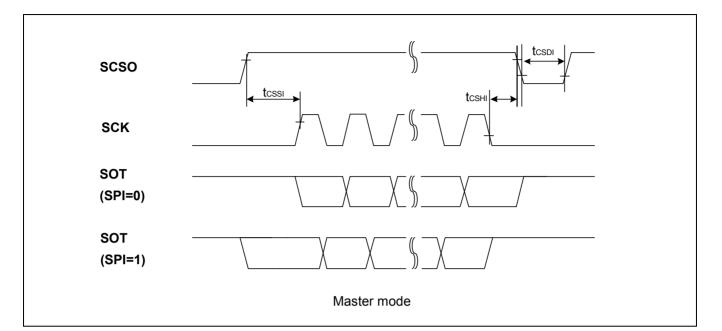
| Parameter | Symbol Conditions | | | Value | | Unit | Remarks |
|-----------------|-------------------|------------|-----|-------|-----|------|-----------|
| | Symbol | Conditions | Min | Тур | Max | Onit | Reillaiks |
| Clock frequency | f _{CRL} | - | 50 | 100 | 150 | kHz | |

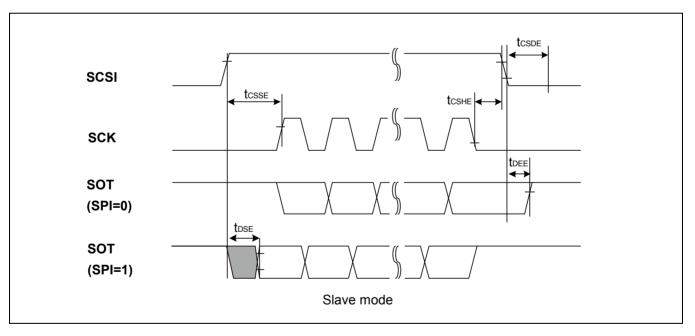








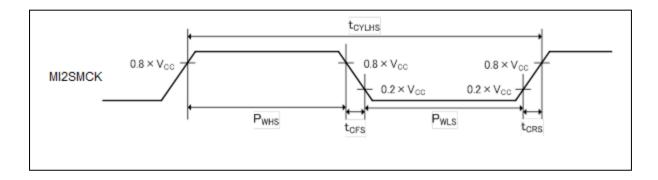






MI2SMCK Input Characteristics

| • • • • • • • • • • • • • • • • • • • | | | | (V _{CC} = 1.65) | V to 3.6 V, \ | / _{SS} = 0 V | ′, T _A =- 40°C to +10 |
|---------------------------------------|--------------------------------------|------------|--|---------------------------|---------------|-----------------------|----------------------------------|
| Parameter | Symbol | Pin Name | Conditions | - | lue | Unit | Remarks |
| T drameter | Cymbol | 1 III Nume | oonanions | Min | Max | onin | Remarks |
| Input frequency | f _{CHS} | MI2SMCK | - | - | 12.288 | MHz | |
| Input clock cycle | t _{CYLHS} | - | - | 81.3 | - | ns | |
| Input clock pulse width | - | - | P _{WHS} /t _{CYLHS} P _{WLS} /t _{CYLHS} | 45 | 55 | % | When using external clock |
| Input clock rise time and fall time | t _{CFS} t _{CRS} | - | - | - | 5 | ns | When using external clock |



MI2SMCK Output Characteristics

(V_{CC}= 1.65 V to 3.6 V, V_{SS}= 0 V, T_A=- 40^{\circ}C to +105 $^{\circ}C$)

| Parameter | Symbol | Symbol Pin Name | Conditions | Va | lue | Unit | Remarks |
|------------------|--|-----------------|------------|-----|-----|-------------------------|-------------------------|
| Falameter | Symbol | Fill Name | Conditions | Min | Max | Unit | Rellidiks |
| Output fraguanay | utput frequency f _{CHS} MI2SMCK | | - | 25 | MHz | V _{CC} ≥ 2.7 V | |
| Output frequency | | MI2SMCK | | - | 20 | MHz | V _{CC} < 2.7 V |



11.6 USB Characteristics

| Parameter | | Symbol | Pin | Conditions | Value | | l lmit | Demerke |
|--------------------------|--------------------------------|---------------|---------------|--|--------------------------|-----------------------|--------|---------|
| | | | Name | | Min | Мах | Unit | Remarks |
| Input characteristics | Input H level voltage | Vін | UDP0, UDM0 | - | 2.0 | V _{CC} + 0.3 | v | *1 |
| | Input L level voltage | VIL | | - | V _{ss} – 0.3 | 0.8 | V | *1 |
| | Differential input sensitivity | Vdi | | - | 0.2 | - | V | *2 |
| | Differential common mode range | Vсм | | - | 0.8 | 2.5 | V | *2 |
| Output characteristic | Output H level voltage | Vон | | External pull-down resistance = 15 kΩ | 2.8 | 3.6 | v | *3 |
| | Output L level voltage | Vol | | External pull-up resistance = 1.5 kΩ | 0.0 | 0.3 | V | *3 |
| | Crossover voltage | VCRS | | - | 1.3 | 2.0 | V | *4 |
| | Rising time | tFR | | Full-speed | 4 | 20 | ns | *5 |
| | Falling time | tFF | | Full-speed | 4 | 20 | ns | *5 |
| | Rising/Falling time matching | t FRFM | | Full-speed | 90 | 111.11 | % | *5 |
| | Output impedance | Zdrv | | Full-speed | 28 | 44 | Ω | *6 |
| | Rising time | tlr | | Low-speed | 75 | 300 | ns | *7 |
| | Falling time | tlf | | Low-speed | 75 | 300 | ns | *7 |
| | Rising/Falling time matching | t LRFM | | Low-speed | 80 | 125 | % | *7 |

(V_{CC}=3.0 V to 3.6 V, V_{SS}=0 V, T_A=- 40°C to +105°C)

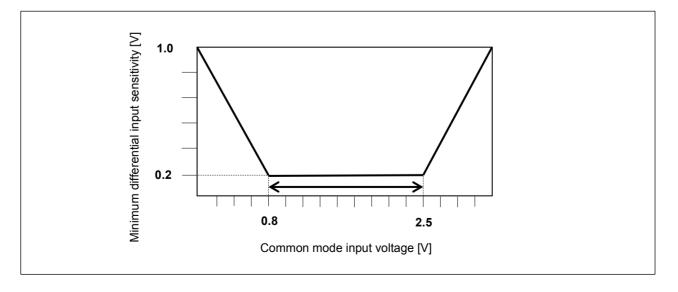
*1 : The switching threshold voltage of single-end-receiver of USB I/O buffer is set as within VIL(Max)=0.8 V, VIH(Min)=2.0 V (TTL input standard).

There are some hysteresis to lower noise sensitivity.

*2 : Use differential-receiver to receive USB differential data signal.

Differential-receiver has 200 mV of differential input sensitivity when the differential data input is within 0.8 V to 2.5 V to the local ground reference level.

Above voltage range is the common mode input voltage range.



*3 : The output drive capability of the driver is below 0.3 V at Low-state (VoL) (to 3.6 V and 1.5 kΩ load), and 2.8 V or above



11.9.2 Return Factor: Reset

The return time from Low-Power consumption mode is indicated as follows. It is from releasing reset to starting the program operation.

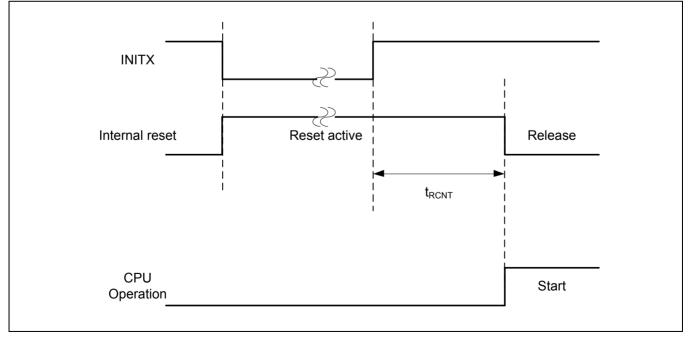
Return Count Time

 $(V_{CC}=1.65 \text{ V to } 3.6 \text{ V}, T_{A}=-40^{\circ}\text{C to } +105^{\circ}\text{C})$

| Param | Symbol | Va | Value | | Domorko | | |
|---|------------------------|-------------------|-------|------|---------|-------------------------------------|--|
| Current Mode | Mode to return | Symbol | Тур | Max* | Unit | Remarks | |
| High-speed CR Sleep mode Main Sleep mode PLL Sleep mode | | | 20 | 22 | μs | When High-speed CR is enabled | |
| Low-speed CR Sleep mode | | | 50 | 106 | μs | When High-speed CR is enabled | |
| Sub Sleep mode | | | 112 | 137 | μs | When High-speed CR is enabled | |
| High-speed CR Timer mode Main Timer mode PLL Timer mode | High-speed CR Run mode | t _{rcnt} | 20 | 22 | μs | When High-speed CR is enabled | |
| Low-speed CR Timer mode | | | 87 | 159 | μs | | |
| Sub Timer mode | | | 148 | 209 | μs | | |
| Stop mode RTC mode | | | 45 | 68 | μs | | |
| Deep Standby RTC mode Deep Standby Stop mode | | | 43 | 281 | μs | | |

*: The maximum value depends on the accuracy of built-in CR.

Operation Example of Return from Low-Power Consumption Mode (by INITX)





12. Ordering Information

| Part number | On-chip Flash memory [Kbyte] | On-Chip SRAM [Kbyte] | Package | Packing |
|-------------------|---------------------------------------|----------------------------|--|---------|
| S6E1C32D0AGV20000 | 128 | 16 | Plastic • LQFP (0.50 mm pitch), 64 pins | Trov |
| S6E1C31D0AGV20000 | 64 | 12 | (FPT-64P-M38) | Tray |
| S6E1C32C0AGV20000 | 128 | 16 | Plastic • LQFP (0.50 mm pitch), 48 pins | Tray |
| S6E1C31C0AGV20000 | 64 | 12 | (FPT-48P-M49) | |
| S6E1C32B0AGP20000 | 128 | 16 | Plastic • LQFP (0.80 mm pitch), 32 pins | Tray |
| S6E1C31B0AGP20000 | 64 | 12 | (FPT-32P-M30) | |
| S6E1C32D0AGN20000 | 128 | 16 | Plastic • QFN64 (0.50 mm pitch), 64 pins | Tray |
| S6E1C31D0AGN20000 | 64 | 12 | (LCC-64P-M25) | |
| S6E1C32C0AGN20000 | 128 | 16 | Plastic • QFN48 (0.50 mm pitch), 48 pins | Tray |
| S6E1C31C0AGN20000 | 64 | 12 | (LCC-48P-M74) | |
| S6E1C32B0AGN20000 | 128 | 16 | Plastic • QFN32 (0.50 mm pitch), 32 pins | Tray |
| S6E1C31B0AGN20000 | 64 | 12 | (LCC-32P-M73) | _ |
| (TBD) | 128 | 16 | WLCSP (TBD) | (TBD) |



13. Package Dimensions

